## Search Notes



Updated search, US-PGPUB, USPAT, EPO, JPO

shape) AND wavelet

East Search Updated

Inventor Search

IEEE Search

STIC Plus Search

Interference Search

## Application/Control No.

10772805

Applicant(s)/Patent Under Reexamination

KEENAN, MICHAEL R.

Examiner

Art Unit

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2624

## SEARCHED

Class	Subclass	Date	Examiner
382	232-253	4/23/2008	ms
356	300-305	4/23/2008	ms
375	240,240.01-240.24	4/23/2008	ms

SEARCH NOTES

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Search Notes	Date	Examiner
keenan-michael\$.in.	6/14/2007	FA
(concentration ADJ3 matrix) AND (spectral ADJ3 shape) AND wavelet	6/18/2007	FA
(principal ADJ3 component\$) AND wavelet\$ AND concentration AND	6/18/2007	FA
image		
(scor\$ ADJ3 matrix) AND (loading ADJ3 matrix) AND wavelet	6/18/2007	FA
((principal\$ ADJ3 component\$) OR SVD) AND matrix AND image AND	6/18/2007	FA
wavelet		
(data ADJ3 factor) AND (concentration ADJ3 matrix) AND (spectral ADJ3	6/19/2007	FA

11/26/2007

4/23/2008

4/23/2008

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	INTERFERENCE SEARCH		
Class	Subclass	Date	Examiner
	DCDLID Toyt Soarch, and attached soarch notes	4/22/2000	me